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FAN7532 Ballast Control IC

Features

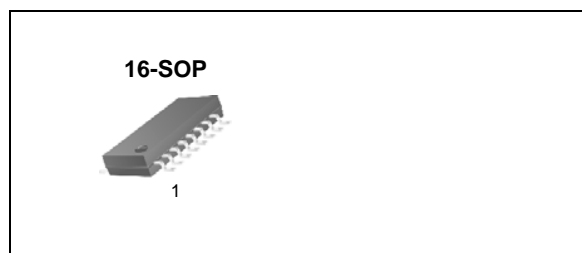
- Floating Channel Designed for Bootstrap Operation to +600V
- Lower di/dt Gate Driver for Better Noise Immunity
- Driver Current Capability: 250mA/500mA (Typ.)
- Low Start-up and Operating Current: 120µA, 6.4mA
- Under-Voltage Lockout (UVLO) with 1.8V of Hysteresis
- Programmable Preheat Time and Frequency
- Programmable Run Frequency
- Protection from Failure to Strike
- Lamp Filament Sensing and Protection
- Automatic Restart for Lamp Exchange
- High-Accuracy Oscillator
- 16-Pin SOP

Applications

- General Purpose Ballast IC

Description

The FAN7532 provides simple and high-performance electronic ballast control functions. Optimized for an electronic ballast, the FAN7532 requires a minimum board area and reduces component counts. The FAN7532 is intended to drive two power MOSFETs in the classical half-bridge topology with all the features needed to properly drive and control a fluorescent lamp. The FAN7532 has many comprehensive protection features that work through filament failure, failure of a lamp to strike, and automatic restarts. A dedicated timing section in the FAN7532 allows the user to set the necessary parameters to preheat, ignite, and run the lamp properly.



Ordering Information

Part Number	Package	Pb-Free	Operating Temperature Range	Packing Method
FAN7532M	16-SOP	Yes	-25°C ~ 125°C	TUBE
FAN7532MX				TAPE & REEL

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Typical Application Circuit

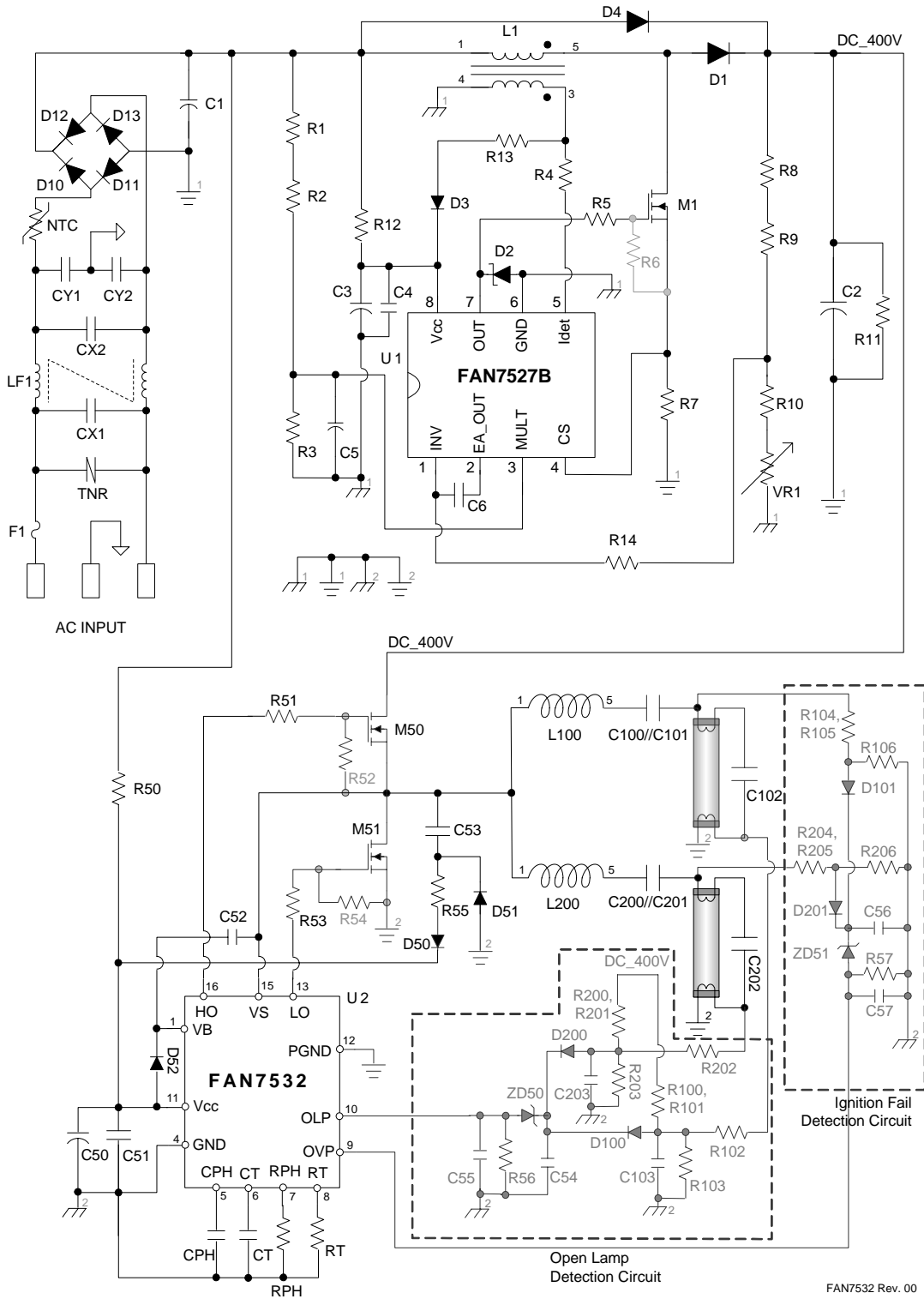


Figure 1. Application Circuit

Internal Block Diagram

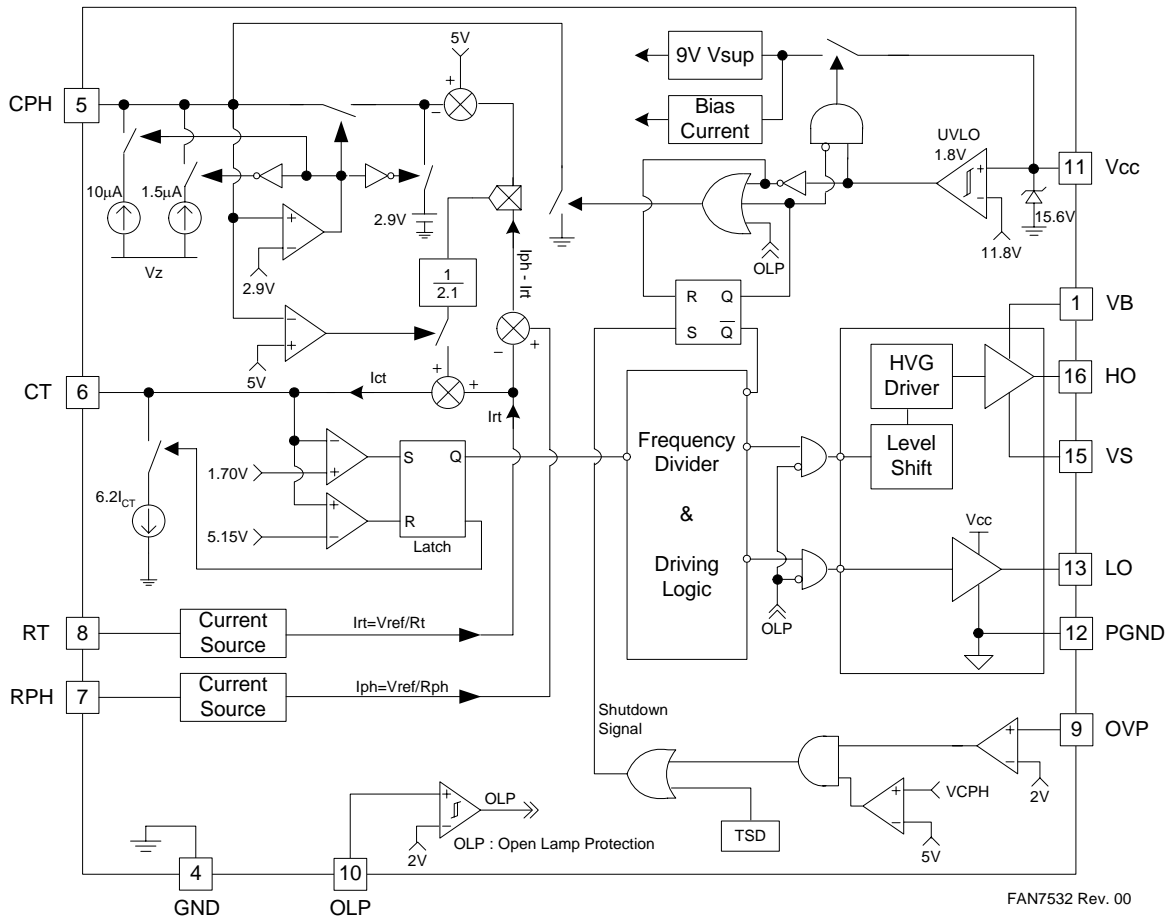


Figure 2. Functional Block Diagram of FAN7532

Pin Configuration

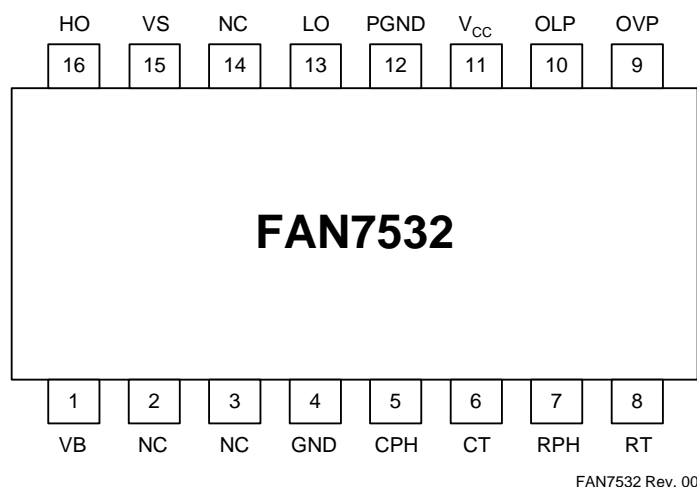


Figure 3. Pin Configuration (Top View)

Pin Definitions

Pin Number	Pin Name	Pin Function Description
1	VB	High-Side Floating Supply Voltage
2	N.C.	No Connection
3	N.C.	No Connection
4	GND	Ground
5	CPH	Preheat Time Set Capacitor
6	CT	Oscillator Frequency Set Capacitor
7	RPH	Preheat Frequency Set Resistor
8	RT	Oscillator Frequency Set Resistor
9	OVP	Over-Voltage Protection, Latch Mode
10	OLP	Open Lamp Protection, Only Output Disable Mode
11	V _{CC}	Supply Voltage
12	PGND	Power Ground
13	LO	Low-Side Gate Driver Output
14	N.C.	No Connection
15	VS	High-Side Floating Supply Return
16	HO	High-Side Gate Driver Output

Absolute Maximum Ratings

The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table defines the conditions for actual device operation. ($T_A = 25^\circ\text{C}$, unless otherwise specified.)

Symbol	Characteristics	Min.	Max.	Unit
I_{CC}	Supply Current (See Caution Below)	-	25	mA
V_S	High-Side Floating Supply Offset Voltage	V_B-25	$V_B+0.3$	V
V_B	High-Side Floating Supply Voltage	-0.3	625	
V_{HO}	High-Side Floating Output Voltage, HO	$V_S-0.3$	$V_S+0.3$	
I_{OH}	Drive Output Source Current		250	mA
I_{OL}	Drive Output Sink Current		500	
V_{IN}	CPH, CT, RT, and RPH Pins Input Voltage	-0.3	6	V
dV_S/dt	Allowable Offset Voltage Slew Rate	-	50	V/ns
T_{opr}	Operating Temperature Range	-25	125	$^\circ\text{C}$
T_{stg}	Storage Temperature Range	-65	150	
P_d	Power Dissipation	-	0.94	W
$R\theta_{ja}$	Thermal Resistance (Junction-to-Air)	-	100	$^\circ\text{C/W}$

Caution:

You must not supply a low-impedance voltage source to the internal clamping zener diode that is between the GND and the V_{CC} pin of this device.

Recommended Operating Conditions

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	11 to V_{CL}	V
V_S	High-Side Floating Offset Supply Voltage	600	V
V_B	High-Side Floating Supply Voltage	V_S+11 to V_S+20	V
V_{HO}	High-Side Floating Output Voltage, HO	V_S to V_B	V

Temperature Characteristics ($-25^\circ\text{C} \leq T_A \leq 125^\circ\text{C}$)

Symbol	Parameter	Value	Unit
Δf_{os} (Typ)	Temperature Stability for Operating Frequency (fos)	3	%

ESD Level

Parameter	Pins	Conditions	Level	Unit
Human Body Model (HBM)	GND, CPH, CT, RPH, RT, OVP, OLP, LO	$R = 1.5\text{k}\Omega$, $C = 100\text{pF}$	± 1000	V
	VB, VS, HO			
Machine Model (MM)	LO	$C=200\text{pF}$	± 250	

Note:

ESD immunity for all pins, except for condition noted above, is guaranteed up to 2000V (Human Body Model) and 300V (Machine Model).

Electrical Characteristics

$V_{CC}=V_{BS}=14V$, $T_A=25^{\circ}C$ unless otherwise specified.

Symbol	Characteristics	Test Condition	Min.	Typ.	Max.	Unit
SUPPLY VOLTAGE SECTION						
$V_{TH(st)}$	Start Threshold Voltage	V_{CC} Increasing	11	11.8	12.6	V
$H_{Y(st)}$	UVLO Hysteresis		0.8	1.8	2.8	V
V_{CL}	Supply Clamping Voltage	$I_{CC} = 12mA$	14.7	15.6	16.5	V
I_{ST}	Start-Up Supply Current	$V_{CC} = 10V$	-	120	180	μA
I_{CC}	Operating Supply Current	Output Not Switching	-	6.4	9.5	mA
I_{DCC}	Dynamic Operating Supply Current: ($I_{CC}+I_{QBS}$)	50kHz, $C_L = 1nF$	-	8.2	10.5	mA
OSCILLATOR SECTION						
I_{CPHL}	CPH Pin Charging Current 1	$V_{CPH} = 2V$	1	1.5	2	μA
I_{CPHH}	CPH Pin Charging Current 2	$V_{CPH} = 4V$	7.7	10	12.3	μA
V_{CLAMP}	CPH Pin Clamp Voltage		5.1	5.65	6.2	V
f_{PH}	Preheating Frequency	$V_{CPH} = 0V$, $R_{PH} = 20k\Omega$, $CT = 1nF$	75	85	95	kHz
t_{PD}	Preheating Dead Time	$V_{CPH} = 0V$, $R_{PH} = 20k\Omega$, $CT = 1nF$	0.75	1.20	1.55	μs
f_{OSC}	Operating Frequency	$V_{CPH} = Open$, $RT = 18k\Omega$, $CT = 1nF$	48	50	52	kHz
t_{OD}	Operating Dead Time	$V_{CPH} = Open$, $RT = 18k\Omega$, $CT = 1nF$	1.5	2	2.3	μs
ΔV_{CT}	Differential Threshold Voltage on CT		3	3.45	4	V
I_{ch}	CT Charging Current	$V_{CT} = 1.5V$	400	460	510	μA
I_{disch}	CT Discharging Current	$V_{CT} = 5.5V$	1.95	2.4	2.8	mA
$\Delta f/\Delta V$	Voltage Stability	$12.7V \leq V_{CC} \leq V_{CL}$	-	-	3	%
OUTPUT SECTION						
I_{LO1}	Low-Side Driver Source Current	$V_{LO} = V_{CC}$	200	250	-	mA
I_{LO2}	Low-Side Driver Sink Current	$V_{LO} = GND$	400	500	-	mA
I_{HO1}	High-Side Driver Source Current	$V_{HO} = V_B$	200	250	-	mA
I_{HO2}	High-Side Driver Sink Current	$V_{HO} = V_S$	400	500	-	mA
t_r	High/Low-Side Rising Time	$C_L = 1nF$	-	90	150	ns
t_f	High/Low-Side Falling Time	$C_L = 1nF$	-	40	100	ns
HIGH-VOLTAGE SECTION						
I_{LK}	Offset Supply Leakage Current	$V_B = V_S = 600V$	-	-	10	μA
I_{QBS}	Quiescent V_{BS} Supply Current		10	48	90	μA
PROTECTION SECTION						
V_{th_com}	OVP/OLP Comparator Threshold Voltage		1.8	2	2.3	V
V_{hy_com}	OLP Comparator Hysteresis Voltage		0.6	0.92	1.3	V
I_{latch}	Latch Mode Quiescent Current		-	0.35	0.45	mA
T_{SD}	Thermal Shutdown Junction Temperature		-	150	-	$^{\circ}C$

Typical Performance Characteristics

These characteristic graphs are normalized at $T_A = 25^\circ\text{C}$.

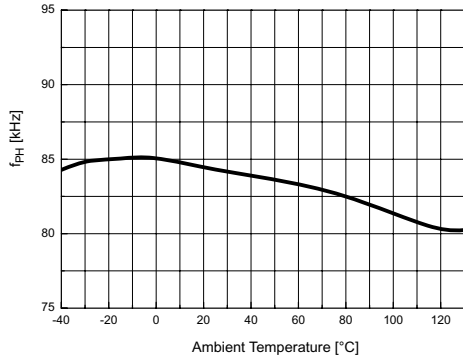


Figure 4. Preheating Frequency vs. Temp.

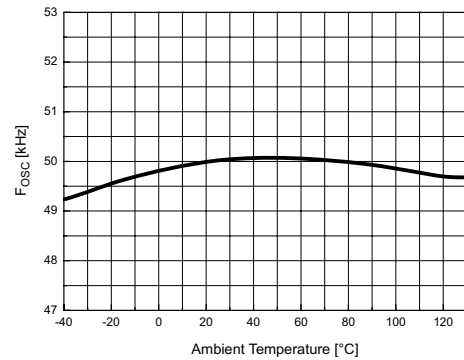


Figure 5. Operating Frequency vs. Temp.

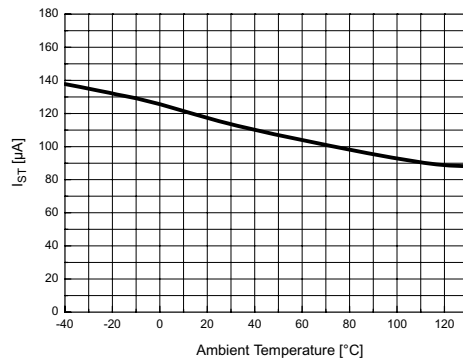


Figure 6. Turn-off Propagation Delay vs. Temp.

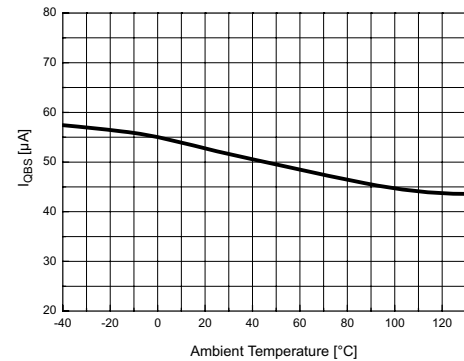


Figure 7. Dynamic Operating Current vs. Temp.

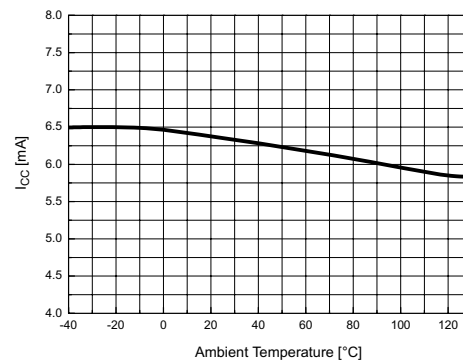


Figure 8. Dynamic Operating Current vs. Temp.

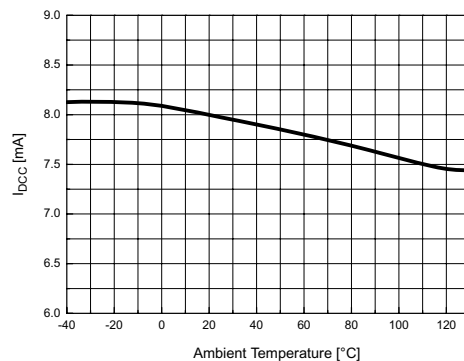


Figure 9. Dynamic Operating Current vs. Temp.

Typical Performance Characteristics (Continued)

These characteristic graphs are normalized at $T_A = 25^\circ\text{C}$.

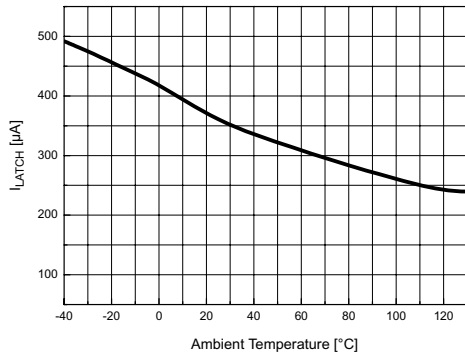


Figure 10. Latch Mode Current vs. Temp.

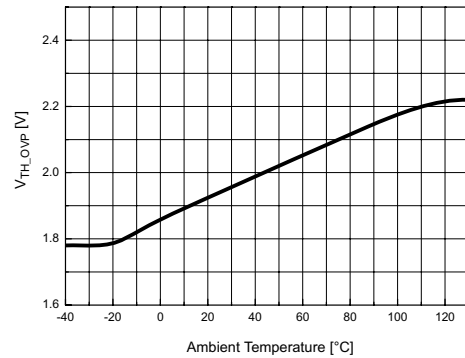


Figure 11. OVP Detection Voltage vs. Temp.

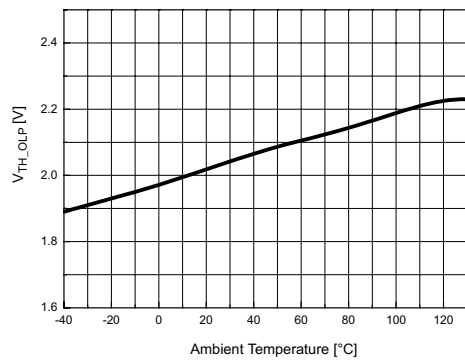


Figure 12. OLP Detection Voltage vs. Temp.

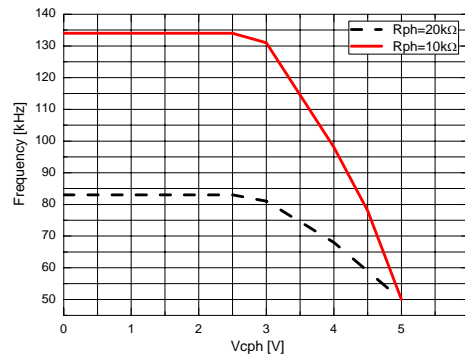


Figure 13. Preheating Frequency vs. Rph

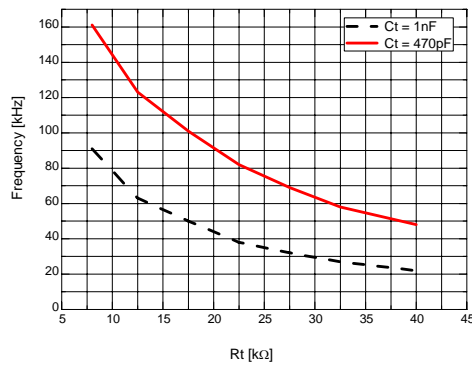


Figure 14. Run Frequency vs. R_t and C_t

Application Information

1. Start-up Circuit

The start-up current is supplied to the IC through the start-up resistor (Rst). To reduce the power dissipation in Rst, Rst is connected to the full-wave, rectified output voltage. The size of Rst can be determined by equations (1) and (2).

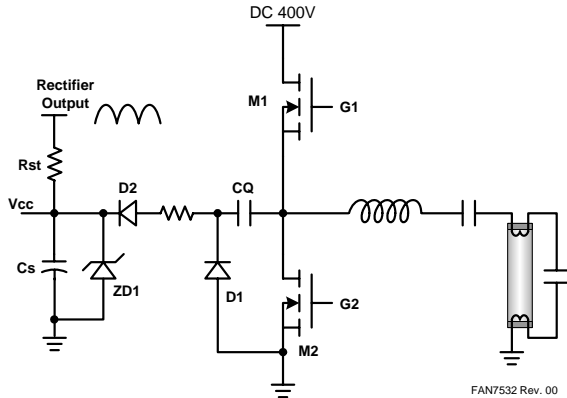


Figure 15. Start-up Circuit

$$R_{st} = \frac{V_{in(ac)} \times \sqrt{2} - V_{th(st).max}}{I_{st,max}} \quad (1)$$

$$= \frac{85 \times \sqrt{2} - 12.4}{0.18 \times 10^{-3}} = 599 \text{ [k}\Omega\text{]}$$

$$R_{st} = \frac{(V_{in(ac,max)} \times \sqrt{2} - V_{cc})^2}{R_{st}} \leq 0.5 \text{ [W]} \quad (2)$$

$$R_{st} \geq 2 \times (V_{in(ac,max)} \times \sqrt{2} - V_{cc})^2$$

$$\geq 260 \text{ [k}\Omega\text{]}$$

$$\therefore 260 \text{ [k}\Omega\text{]} \leq R_{st} \leq 599 \text{ [k}\Omega\text{]}$$

The size of supply capacitor (Cs) is normally determined by the start-up time and the operating current which is built up by the auxiliary operating current source. The turn-off snubber capacitor (CQ) and two diodes (D1, D2) constitute the auxiliary operating current source for the IC. The charging current through the CQ flows into the IC and charges the supply capacitor. If the size of CQ is increased, the V_{CC} voltage on the Cs is also increased.

2. Under-Voltage Lockout (UVLO)

The UVLO mode of the FAN7532 is designed to maintain an ultra low supply current of less than 120μA, and to guarantee that the IC is fully functional before two output drivers are activated.

3. Oscillator

The gate drive output frequency is half that of the triangular waveform on timing capacitor (CT) at pin #6. In normal operating mode, the timing capacitor charging current is 4•I_rt (=V_{ref}/RT). The discharging current is 6.2 times the charging current. During the charging period of the timing capacitor (CT), the MOSFET alternatively turns on. During the discharging period of the timing capacitor (CT), both MOSFETs are off.

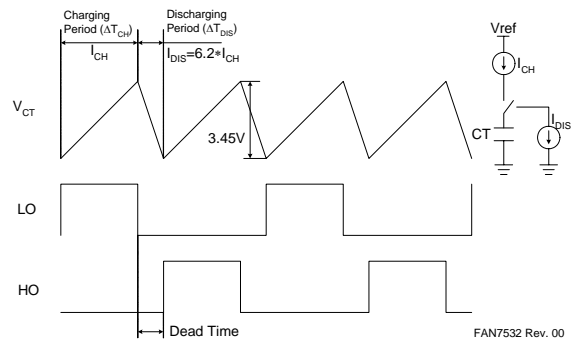


Figure 16. CT & Output Waveforms

The FAN7532 has three operating modes according to V_{CPH}, as shown in Figure 17.

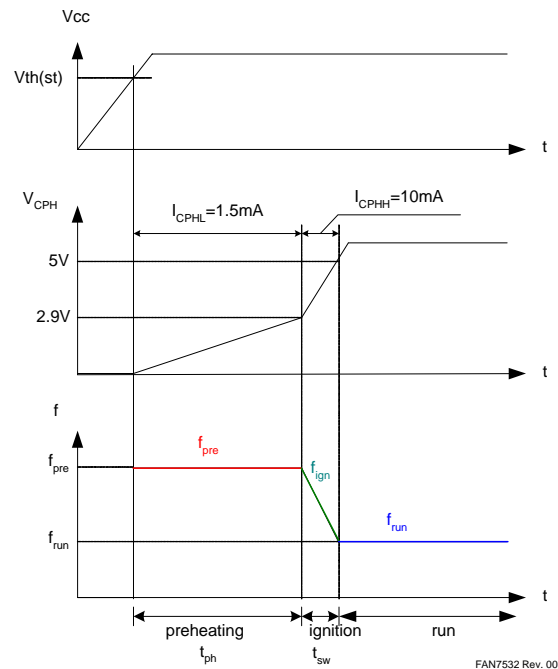


Figure 17. Operating Modes

$0V \leq V_{CPH} \leq 2.9V$, ;Preheating Frequency

$$I_{CT} = I_{RT} + \frac{I_{PH} - I_{RT}}{(5V - 2.9V)}(5V - 2.9V) = I_{PH}$$

$2.9V \leq V_{CPH} \leq 5V$, ; Ignition Frequency

$$I_{CT} = I_{RT} + \frac{I_{PH} - I_{RT}}{(5V - 2.9V)}(5V - V_{CPH})$$

$V_{CPH} \geq 5V$

$I_{CT} = I_{RT}$, ;Run Frequency

4. Preheating Mode

The preheating mode is defined as the IC's internal status when the V_{CPH} is between 0V and 2.9V. During preheating, the current that flows through the ballast circuit heats the lamp filaments. This is necessary for maximizing lamp life and reducing the required ignition voltage. When the V_{CC} exceeds the UVLO high threshold, the preheating time set-up capacitor, CPH, starts being charged by the internal 1.5μA current source until the V_{CPH} reaches 2.9V. Until the V_{CPH} reaches 2.9V, the switching frequency throughout the preheating mode is determined by CT and RPH.

The preheating time is determined by the CPH and the 1.5μA current source. Therefore, the preheating time is determined by equation (3):

$$t_{pre} = CPH \times \frac{V_{CPH}}{I_{charging}} \quad (3)$$

The preheating frequency is determined by the amount of charging and discharging current to the CT capacitor. The charging and discharging current during preheating mode is decided by equation (4):

$$I_{pre_ch} = 4 \times \frac{V_{ref}}{R_{PH}} \quad (4)$$

$$I_{pre_disch} = 4 \times \frac{(6.25 \times V_{ref})}{R_{PH}}, \quad V_{ref} = 4V \text{ (Constant)}$$

The charging and discharging time of the CT capacitor during preheating mode is decided by equation (5):

$$t_{pre_ch} = C_T \times \frac{dV_{CT}}{I_{pre_ch}} \quad (5)$$

$$t_{pre_disch} = C_T \times \frac{dV_{CT}}{I_{pre_disch}}, \quad dV_{CT} = 3.45V \text{ (Constant)}$$

Finally, the FAN7532's preheating frequency in the preheating period is determined by equation (6):

$$f_{pre} = \frac{1}{2 \times (t_{pre_ch} + t_{pre_disch})} \quad (6)$$

5. Ignition Mode

The ignition mode is defined as the IC's internal status when V_{CPH} is approximately between 2.9V and 5V. During ignition, the operating frequency is decreased to a pre-determined value. At the same time, a very high-voltage for igniting the lamp is established across the lamp. When the V_{CPH} exceeds 2.9V, the FAN7532 enters the ignition mode. Once V_{CPH} exceeds 5V, the device enters the run mode described in the following section. In the ignition period, the internal 10mA current source charges the external preheating timing capacitor (CPH) to increase noise immunity with the sharp slope of the V_{CPH} . The ignition time is determined by the CPH and internal 10mA current source ($\Delta T_{ign} = CPH \times \frac{\Delta V_{CPH}}{I_{CPH}}$). In this mode, the switching frequency is determined by CT, RPH, and RT. Therefore, the charging and discharging currents change according to V_{CPH} and are determined by equation (7).

$$I_{CT} = I_{RT} + \frac{I_{PH} - I_{RT}}{(5V - 2.9V)}(5V - V_{CPH}) \quad (7)$$

6. Run Mode

After the lamp has successfully ignited, the FAN7532 enters run mode. The run mode is defined as the IC's internal status when V_{CPH} is higher than 5V. In this mode, the lamp is being driven with a normal power level after the lamp is discharged. The run mode switching frequency is determined by the timing resistor RT and the timing capacitor CT. When the V_{CPH} exceeds 5V, the protection-masking mode is disabled and the IC can enter the protection mode. The running frequency is determined by the amount of charging and discharging current to CT capacitor.

The charging and discharging currents during preheating mode are decided by the equation (8):

$$I_{run_ch} = 2 \times \frac{V_{ref}}{R_T} \quad (8)$$

$$I_{run_disch} = 2 \times \frac{(6.25 \times V_{ref})}{R_T}, \quad V_{ref} = 4V \text{ (Constant)}$$

$$t_{run_ch} = C_T \times \frac{dV_{CT}}{I_{run_ch}} \quad (9)$$

$$t_{run_disch} = C_T \times \frac{dV_{CT}}{I_{run_disch}}, \quad dV_{CT} = 3.45V \text{ (Constant)}$$

Finally, the preheating frequency in the preheating period using the FAN7532 is determined by the equation (10):

$$f_{run} = \frac{1}{2 \times (t_{run_ch} + t_{run_disch})} \quad (10)$$

7. Protection Modes

The FAN7532 has two types of protection modes.

1) Over-Voltage Protection (OVP) Mode

The OVP pin is normally connected to the external components that detect lamp voltage between a lamp's cathodes. This voltage is always maintained under 2V in normal operation. If the lamp enters the end-lamp-life or abnormal condition, the lamp does not turn-on even if there is enough voltage supplied between two cathodes. Normally, this condition means that one of the cathodes

is broken, deactivated, or the lamp is deeply blackened around the cathodes. In this state, the ballast constantly generates very high voltage between two cathodes to ignite according to a specific procedure in the control IC. When the voltage of OVP pin exceeds 2V, the IC instantly enters the protection mode. To exit this mode, the V_{CC} must be recycled below the UVLO low threshold.

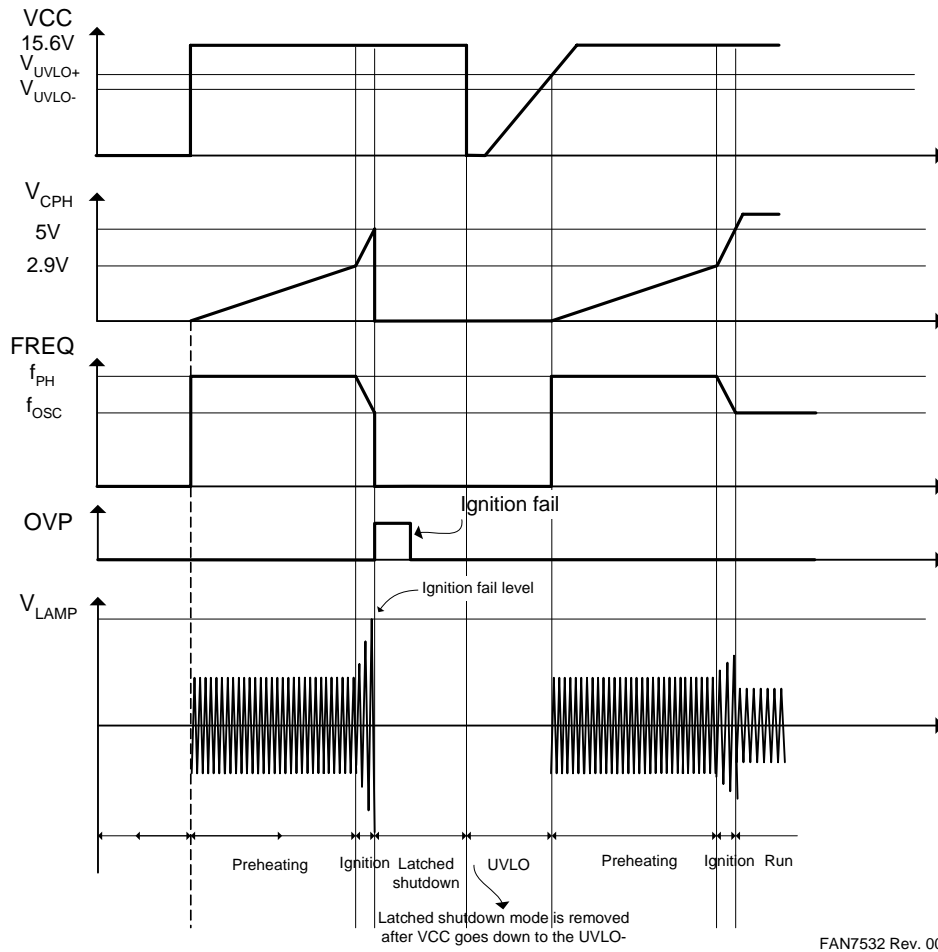


Figure 18. Timing Diagram (OVP Mode)

FAN7532 Rev. 00

2) Open Lamp Protection (OLP) Mode

After the lamp has successfully ignited, the FAN7532 enters run mode. In this mode, if one of the cathodes isn't correctly connected to the ballast, the ballast stops operation for safety until the lamp is changed and a new one is connected between the lamp and the ballast. As soon as the voltage of OLP pin exceeds 2V, the IC

enters the protection mode. However, the FAN7532 outputs are only disabled in this mode. To exit protection mode, the lamp must be replaced or correctly connected to the ballast.

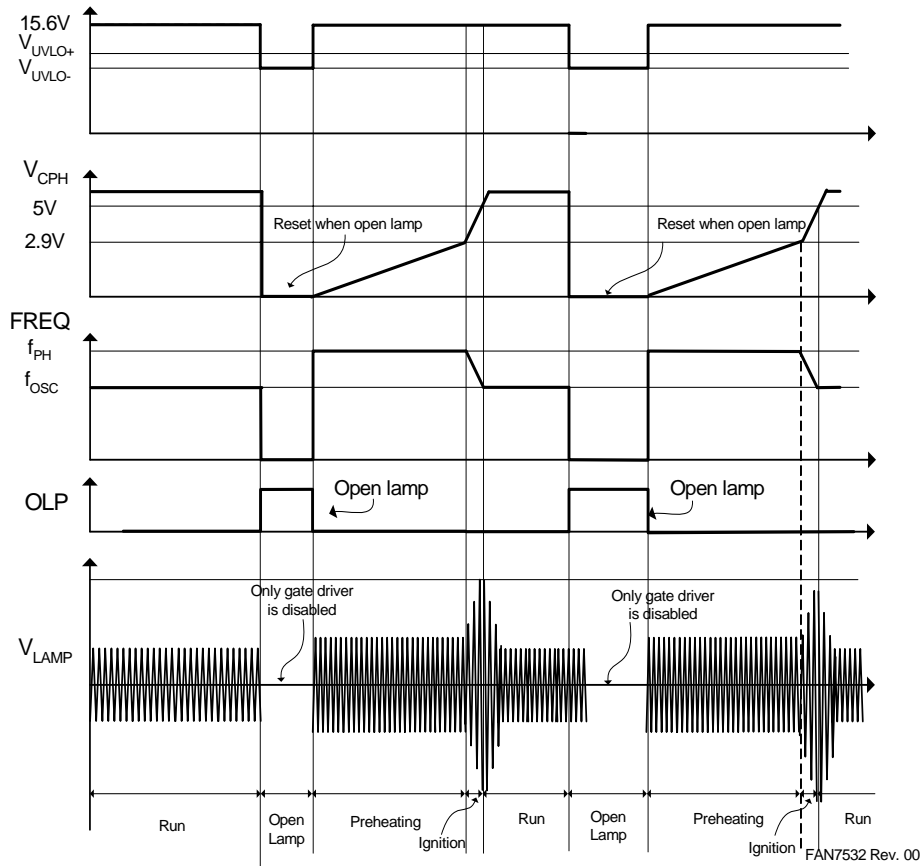


Figure 19. Timing Diagram (OLP Mode)

8. PCB Layout Guides

Component selection and placement on the PCB is very important when using power control ICs. Bypass the V_{CC} to GND as close to the IC terminals as possible with a low ESR/ESL capacitor, as shown in Figure 20. This bypassed capacitor can reduce the noise from the power supply parts, such as a startup resistor and a charge pump. The GND lead should be directly connected to the low-side power MOSFET using an individual PCB trace. In addition, the ground return path of the timing components (CPH, CT, RPH, RT) and V_{CC} decoupling capacitor should be connected directly to the IC GND lead and not via separate traces or jumpers to other ground traces on the board. These connection techniques prevent high-current ground loops from interfering with sensitive timing component operations and allow the entire control

circuit to reduce common-mode noise due to output switching.

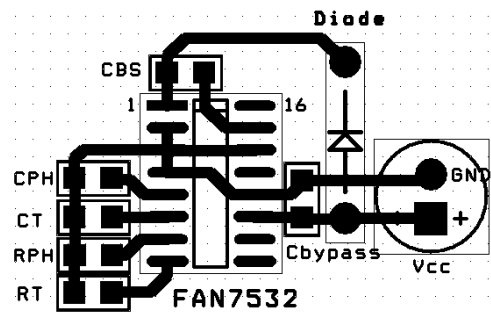


Figure 20. PCB Layout

Components List

(for Wide-Range 32W× 2 Lamps Application)

Part number	Value	Note	Manufacturer
INPUT PART			
F1	250V, 3A	Fuse	
CX1	47nF, 275Vac	Box-Cap	
CX2	150nF, 275Vac	Box-Cap	
CY1, CY2	2200pF, 3000V	Y-Cap	
TNR	470V	471	
NTC	10Ω	10D09	
D10, D11, D12, D13	400V, 1A	1N4004	Fairchild Semiconductor
LF1	45mH		
PFC PART			
R1, R2, R8	910kΩ	Ceramic, 1206	
R3	22kΩ	Ceramic, 1206	
R4	22kΩ	Ceramic, 1206	
R5	10Ω	Ceramic, 1206	
R6	22kΩ	Ceramic, 1206	
R7	0.47Ω	1W	
R9	100kΩ	Ceramic, 1206	
R10	2.2kΩ	Ceramic, 1206	
R11	220kΩ	1W	
R12	150kΩ	1W	
R13	4.7Ω	Ceramic, 1206	
R14	0Ω	Ceramic, 1206	
VR1	10kΩ	Variable Resistor	
C1	0.22μF, 630V	Mylar-Cap	
C2	47μF, 450V	Electrolytic	
C3	10μF, 50V	Electrolytic	
C4	105	Ceramic, 0805	
C5	102	Ceramic, 0805	
C6	105	Ceramic, 0805	
L1	0.9mH (80T:6T)	EI2820	
D1, D4	600V, 1A, Ultrafast	UF4005	Fairchild Semiconductor
D2	Schottky Diode	MBR0540	Fairchild Semiconductor
D3	Small Signal Diode	FDLL4148	Fairchild Semiconductor
M1	500V, 6A, Power MOSFET	FQP6N50C, FQPF6N50C	Fairchild Semiconductor
U1	PFC IC	FAN7527B	Fairchild Semiconductor

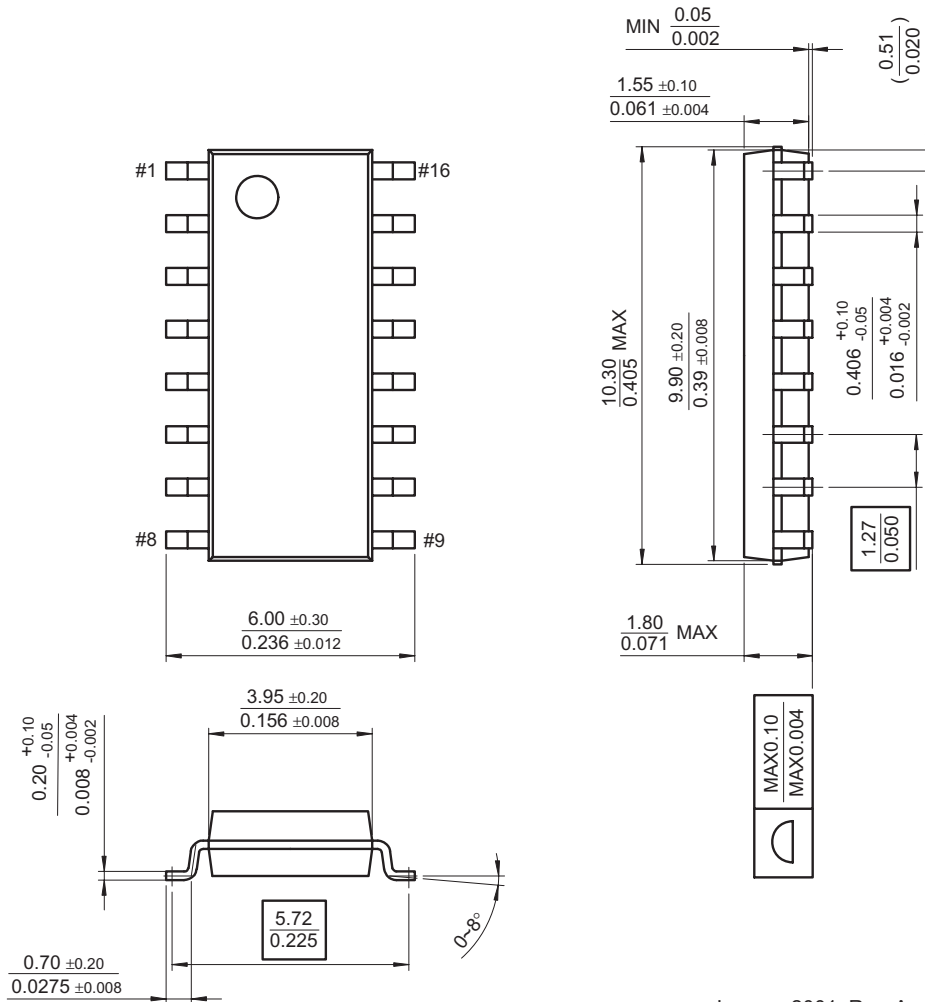
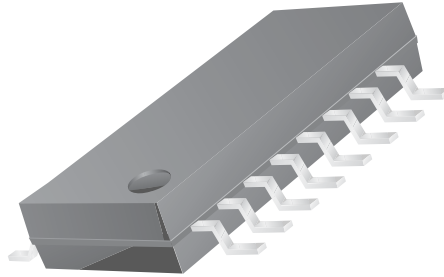
Components List (Continued)

Part number	Value	Note	Manufacturer
BALLAST PART			
R50	390kΩ	1W	
R51, R53	39Ω	Ceramic, 1206	
R52, R54	47kΩ	Ceramic, 1206	
R55	5.6Ω	1W	
R56, R57	68kΩ	Ceramic, 0805	
RPH	27kΩ	Ceramic, 1206, 1%	
RT	18kΩ	Ceramic, 1206, 1%	
R100, R104, R200, R204	910kΩ	Ceramic, 1206	
R101, R105, R201, R205	300kΩ	Ceramic, 1206	
R102, R202	5.1kΩ	Ceramic, 1206	
R103, R203	68kΩ	Ceramic, 1206	
R106, R206	30kΩ	Ceramic, 1206	
C50	10μF, 50V	Electrolytic	
C51	105	Ceramic, 0805	
C52	104	Ceramic, 1206	
C53	681, 630V	Miller-Cap	
C54, C55, C56, C57, C103, C203	104	Ceramic, 0805	
CT	1nF	Ceramic, 0805, 5%	
CPH	680nF	Ceramic, 0805	
C100, C101, C200, C201	6.8nF, 630V	Mylar-Cap	
C102, C202	3.3nF, 1000V	Mylar-Cap	
L100, L200	3.2mH (120T)	EE2820	
M50, M51	500V, 5A, Power MOSFET	FQP5N50C, FQPF5N50C	Fairchild Semiconductor
ZD50, ZD51	Zener Diode	1N5245	Fairchild Semiconductor
D50, D51, D52	600V, 1A, Ultrafast	UF4005	Fairchild Semiconductor
D100, D101, D200, D201	Small Signal Diode	FDLL4148	Fairchild Semiconductor
U2	Ballast IC	FAN7532	Fairchild Semiconductor

Package Dimensions

16-SOP

Dimensions in millimeters



January 2001, Rev. A

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EnSigna™	ImpliedDisconnect™	OCXPro™	µSerDes™	UHC™
FACT™	IntelliMAX™	OPTOLOGIC®	ScalarPump™	UniFET™
FACT Quiet Series™		OPTOPLANAR™	SILENT SWITCHER®	UltraFET®
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PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
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